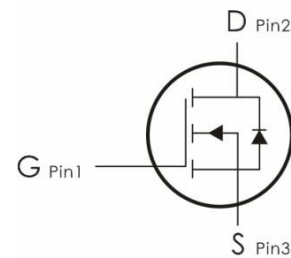
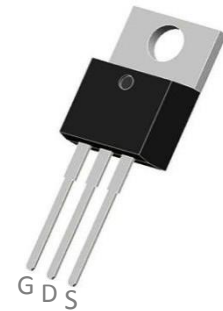


## Description:

This N-Channel MOSFET uses advanced SGT technology and design to provide excellent  $R_{DS(on)}$  with low gate charge. It can be used in a wide variety of applications.

## Features:

- 1)  $V_{DS}=120V, I_D=110A, R_{DS(ON)} < 6.5m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low  $R_{DS(ON)}$ .
- 5) Excellent package for good heat dissipation.



## Absolute Maximum Ratings: ( $T_J=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	120	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current <sup>1</sup> $T_C=25^\circ C$	110	A
$E_{AS}$	Single Pulse Avalanche Energy <sup>5</sup>	400	mJ
$P_D$	Power Dissipation	192	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55-+150	$^\circ C$

## Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.65	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>4</sup>	62	

Electrical Characteristics: ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu A$	120	---	---	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=120V$	---	---	1	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu A$	2	---	4	V
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS}=10V, I_D=30A$	---	5.0	6.5	$m\ \Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=50V, V_{GS}=0V, f=100\ \text{KHz}$	---	5000	---	pF
$C_{oss}$	Output Capacitance		---	650	---	
$C_{rss}$	Reverse Transfer Capacitance		---	17	---	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{GS}=10V, V_{DS}=50V, I_D=25A,$ $R_G=2\ \Omega$	---	30	---	ns
$t_r$	Rise Time		---	32	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	54.5	---	ns
$t_f$	Fall Time		---	11	---	ns
$Q_g$	Total Gate Charge	$V_{GS}=10V, V_{DS}=50V,$ $I_D=25A$	---	65	---	nC
$Q_{gs}$	Gate-Source Charge		---	16	---	nC
$Q_{gd}$	Gate-Drain "Miller" Charge		---	13.5	---	nC
<b>Drain-Source Diode Characteristics</b>						
$V_{SD}$	Source-Drain Diode Forward Voltage	$V_{GS}=0V, I_S=30A$	---	---	1.3	V
$I_S$	Diode Forward Current	$V_{GS}<V_{th}$	---	---	110	A
$I_{SP}$	Pulsed source current		---	---	330	

<b>Trr</b>	Reverse Recovery Time	$I_S=25A, di/dt=100A/\mu S$	---	85	---	NS
<b>Qrr</b>	Reverse Recovery Charge		---	240	---	NC
<b>Irrm</b>	Peak reverse recovery current		---	4.6	---	A

### Notes:

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) Pd is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_a=25^\circ C$ .
- 5)  $V_{DD}=50 V, R_G=50 \Omega, L=0.3 mH$ , starting  $T_j=25^\circ C$ .

### Typical Characteristics: ( $T_j=25^\circ C$ unless otherwise noted)

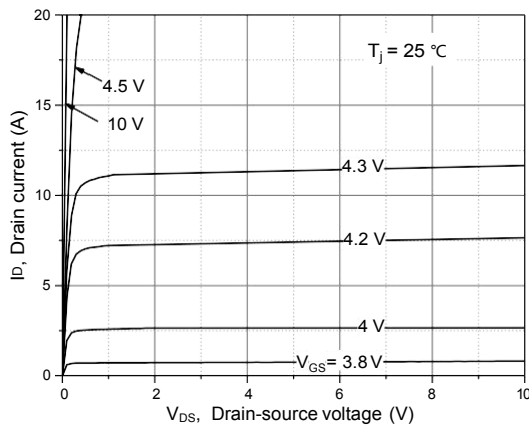


Figure 1, Typ. output characteristics

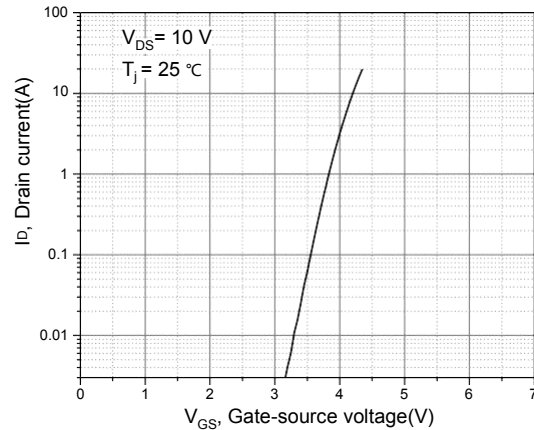


Figure 2, Typ. transfer characteristics

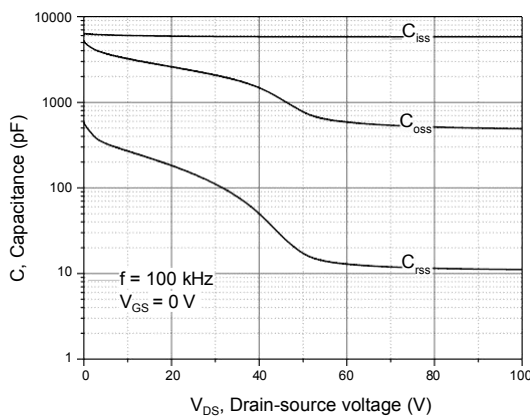


Figure 3, Typ. capacitances

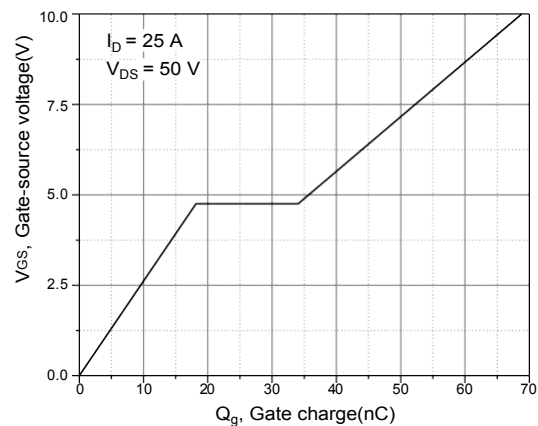


Figure 4, Typ. gate charge

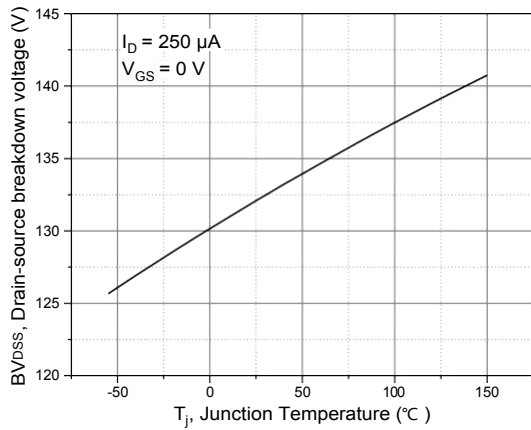


Figure 5, Drain-source breakdown voltage

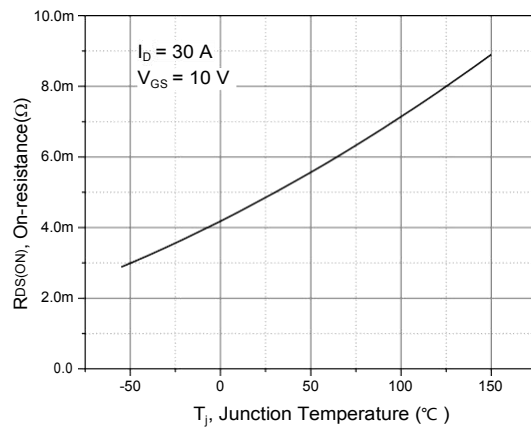


Figure 6, Drain-source on-state resistance

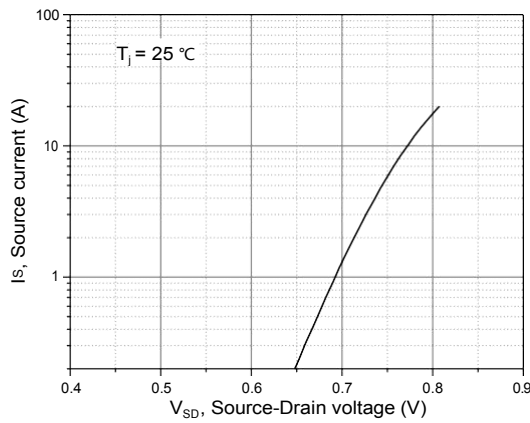


Figure 7, Forward characteristic of body diode

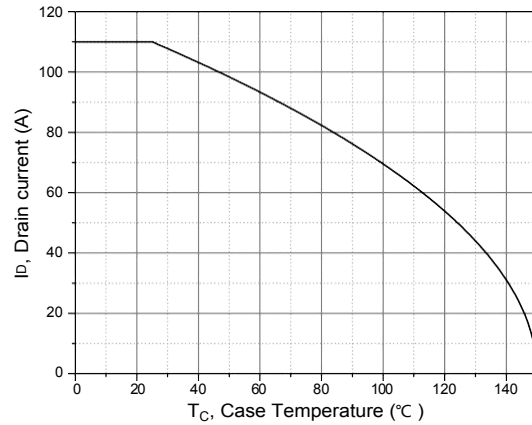


Figure 8, Drain current

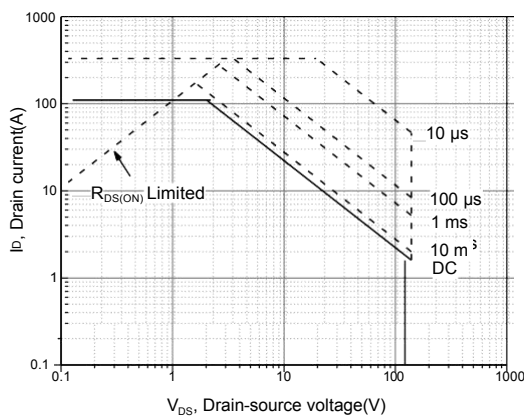


Figure 9, Safe operation area  $T_c=25\text{ }^\circ\text{C}$



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